Two-Dimensional Superconductivity at the LaAlO₃/KTaO₃(110) Heterointerface

Zheng Chen,¹ Zhongran Liu,² Yanqiu Sun,¹ Xiaoxin Chen,² Yuan Liu,⁹,¹ Hui Zhang,³ Hekang Li,¹ Meng Zhang,¹

Siyuan Hong,¹ Tianshuang Ren,¹ Chao Zhang,⁴ He Tian,² Yi Zhou⁽⁰⁾,^{3,5,6} Jirong Sun⁽⁰⁾,^{3,5,7} and Yanwu Xie^(1,8,*)

¹Interdisciplinary Center for Quantum Information, State Key Laboratory of Modern Optical Instrumentation, and Zhejiang Province

Key Laboratory of Quantum Technology and Device, Department of Physics, Zhejiang University, Hangzhou 310027, China

²Center of Electron Microscope, State Key Laboratory of Silicon Materials, School of Materials Science and Engineering, Zhejiang University, Hangzhou, 310027, China

³Beijing National Laboratory for Condensed Matter Physics and Institute of Physics, Chinese Academy of Sciences, Beijing 100190, China

⁴Instrumentation and Service Center for Physical Sciences, Westlake University, Hangzhou 310024, China

⁵Songshan Lake Materials Laboratory, Dongguan, Guangdong 523808, China

⁶Kavli Institute for Theoretical Sciences and CAS Center for Excellence in Topological Quantum Computation,

University of Chinese Academy of Sciences, Beijing 100190, China

⁷Spintronics Institute, University of Jinan, Jinan, Shandong 250022, China

⁸Collaborative Innovation Center of Advanced Microstructures, Nanjing University, Nanjing 210093, China

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We report on the observation of a $T_c \sim 0.9$ K superconductivity at the interface between LaAlO₃ film and the 5*d* transition metal oxide KTaO₃(110) single crystal. The interface shows a large anisotropy of the upper critical field, and its superconducting transition is consistent with a Berezinskii-Kosterlitz-Thouless transition. Both facts suggest that the superconductivity is two-dimensional (2D) in nature. The carrier density measured at 5 K is $\sim 7 \times 10^{13}$ cm⁻². The superconducting layer thickness and coherence length are estimated to be ~ 8 and ~ 30 nm, respectively. Our result provides a new platform for the study of 2D superconductivity at oxide interfaces.

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Oxide interfaces exhibit a rich variety of emergent phenomena [1]. One remarkable observation is the twodimensional (2D) superconductivity that exists at interfaces between two nonsuperconducting constituents [2–9]. Two well-known examples are the LaAlO₃/SrTiO₃(LAO/STO) heterostructure [2] and the La₂CuO₄/La_{2-x}Sr_xCuO₄ bilayer [4]. In both cases, the formation of interface induces charge carriers (electrons or holes) in the parent compound (STO or La₂CuO₄) and confines them near the interface. These superconducting interfaces provide an ideal ground for studying 2D superconductivity and are relevant to understanding the high-temperature superconductor-based devices.

In previous studies [2,3,6,9–12], the STO-based superconducting interfaces, particularly LAO/STO, have attracted considerable interest, although their critical temperature T_c is low (<0.3 K). The parent compound STO is a wideband insulator (semiconductor) and is the first known superconducting semiconductor [13]. One important feature of STO-based interface superconductivity is its high controllability by applying a gate voltage [3,14,15], owing to its low carrier density and the large dielectric constant of STO. In addition, it exhibits a few remarkable properties, such as the coexistence with ferromagnetism [15–17], high-temperature superconductorlike gap behavior [18], and multiple quantum criticality [10]. In addition to STO, $KTaO_3$ (KTO) is another versatile oxide that has attracted much attention due to its interesting dielectric, photoconductive, and optical properties [19]. KTO is in many ways similar to STO [20,21]. Both of them are of perovskite structure, are incipient ferroelectrics characterized by extremely large dielectric constants at low temperatures, and have similar band structures [22]. While the conduction band of STO is in a 3d band associated with the titanium ions, the conduction band of KTO is in a 5d band associated with the tantalum ions. In analogy with the STO-based interfaces, the KTO-based interfaces can also host 2D electron gases [23–25]. However, unlike STO, superconductivity has never been reported in chemically doped KTO [20,26]. It was only reported in the surface of KTO(001) single crystal gated by an electric double-layer technique, with an extremely low $T_c \sim 50$ mK [26]. Surprisingly, very recently, Liu et al. [27] observed superconductivity with a high T_c (~2 K) at the interfaces between EuO (or LAO) and (111)-oriented KTO single crystal. By contrast, they detected no superconductivity (down to 25 mK) at the corresponding KTO(001) interfaces [27]. In addition to (001) and (111), (110) is another principal orientation for perovskite structure. In this Letter, we report on the



FIG. 1. Structural characterization of a 20-nm LAO/KTO(110) heterostructure. (a) HAADF-STEM image shows that the LAO film is amorphous. The inset shows the image with a higher magnification and the atomic configuration (colored) of KTO. (b) EDS elemental mapping of the same sample. The top-left corner panel is the HAADF image of the region for EDS mapping. For comparison, the EDS mapping images of different elements (La, Ta, Al, and K) are presented both together and separately. The interface is abrupt, and intermixing is not significant. At the interface, about one monolayer of K is missing, and as a result, a La-rich layer is formed. The dashed line indicates the position of interface.

existence of 2D superconductivity ($T_c \sim 0.9$ K) at (110)oriented KTO interfaces.

Our samples were prepared by depositing LAO films on KTO(110) single crystal substrates by pulsed laser deposition (see Supplemental Material [28]). The typical growth temperature is 620 °C; the typical growth atmosphere is 1×10^{-5} mbar O₂ (adding a tiny amount of H₂O vapor, 1×10^{-7} mbar). After growth, the samples were cooled to room temperature under the same atmosphere. Atomic force microscopy characterizations (Fig. S1 [28]) show that the surfaces of both KTO substrates and LAO films are very smooth, with a root-mean-square roughness of ~ 0.2 nm. X-ray diffraction shows no epitaxial peaks of LAO (Fig. S2), indicating that the LAO film is not in a welldefined crystalline state. Scanning transmission electron microscopy (STEM) high-angle annular dark-field (HAADF) images taken from a 20-nm LAO/KTO(110) heterostructure are given in Figs. 1(a) and S3(a). The interface is abrupt and smooth. The KTO substrate near the interface is in a well-crystalline state, while the LAO film is amorphous. Note that the LAO films grown on KTO(001) [23] and KTO(111) [27] substrates were also found to be amorphous, probably due to the large lattice mismatch between LAO (0.379 nm) and KTO (0.399 nm). Atomicscale energy-dispersive x-ray spectroscopy (EDS) elemental mapping was performed on the same sample [Figs. 1(b) and S3(b)]. The EDS maps show that the topmost K layer is missing, forming a one-unit-cell La-Ta layer. Except for this layer, the interface is chemically abrupt, and the atomic intermixing is limited to about one unit cell. X-ray photoemission spectroscopy core-level measurements (Fig. S4) confirm that there exists no metallic Al or Ta in our samples.



FIG. 2. (a) Schematic view of the samples. (b) A photo of the central Hall bar area. The interface of the Hall bar region (light) is conducting; other regions (dark) are insulating. (c) Dependence of R_{sheet} on *T* of the 6- and 20-nm samples measured in a wide temperature range. (d) Dependence of R_{Hall} on magnetic field $\mu_0 H$. (e) Dependence of R_{sheet} on *T* in low temperatures.

We examined the electrical transport properties of the LAO/KTO(110) samples. More than ten samples have been measured, ensuring reproducibility. In the following, we present the results of two typical samples that have been prepatterned into a 20-µm-wide Hall bar configuration [Figs. 2(a) and 2(b)] (see Supplemental Material [28]). The samples are metallically conducting in a wide temperature range [Fig. 2(c)], indicating the formation of electron gas at the interface. The magnetic-field-dependent Hall resistance R_{Hall} measured at T = 5 K [Fig. 2(d)] confirms that the charge carriers are electrons; the 2D Hall carrier densities n_{2D} of the 6- and 20-nm samples are 7.1×10^{13} and 6.7×10^{13} cm⁻², and the mobilities 81.6 and 80.8 cm² V⁻¹ s⁻¹, respectively. It is evident that the electron gas locates in KTO, rather than LAO, near the interface, because the band gap of LAO (5.6 eV) is much larger than that of KTO (3.6 eV). This conclusion is supported by many previous studies, which have already showed that the LAO films are highly insulating [30–32]. while electron gas can be formed on the surface (interface) of KTO [23,25,26,33,34]. Interestingly, the normal-state sheet resistance $R_{\text{sheet}}(T)$ shows a nearly linear dependence on T, which is apparently similar to that observed for the $La_2CuO_4/La_{2-r}Sr_rCuO_4$ bilayer [4], but dissimilar to the LAO/STO heterostructure [2] and the LAO/KTO(001)[23] or LaTiO₃/KTO(001) [25] heterostructures. This kind of $R_{\text{sheet}}(T)$ characteristic is indicative of a non-Fermi liquid behavior [35]. Further study is needed to verify this, which is beyond the scope of the present Letter.

As the origin of the electron gas is concerned, in analogy with STO-based interfaces [31,32,36-39], we consider three possibilities: polar-discontinuity-induced electronic reconstruction [37], interface chemistry (i.e., the substitution of K with La) [38], and oxygen vacancies (in both KTO and LAO) [31,32,36]. The polar discontinuity and other structure-related scenarios can be ruled out because the LAO film is amorphous. The interface chemistry can also be fairly ruled out because STEM and EDS characterizations demonstrate that the interface intermixing is not significant (Figs. 1 and S3 [28]). Thus, the most likely scenario is the oxygen vacancies. This scenario is supported by the fact that the LAO/KTO(110) interfaces are less conducting if they have been grown or postannealed in an oxygen-rich environment (Fig. S5). In addition, we found that adding a tiny amount of water vapor can enhance the interface conductance (Fig. S6), presumably due to the interaction of water vapor with oxygen vacancies in LAO [31].

Next, we turn to the occurrence of interface superconductivity. As shown in Figs. 2(c) and 2(e), at low temperatures the $R_{\text{sheet}}(T)$ curves of both samples drop sharply, undergoing a transition to the superconducting state. The zero-resistance state is observed at ~0.54 and ~0.59 K, respectively, for the 6- and 20-nm samples. The midpoint T_c 's, defined as 50% normal-state resistance, are 0.80 and 0.93 K for the 6- and 20-nm samples, respectively. The widths of the transitions (20%–80%) of the 6- and 20-nm samples are 0.11 and 0.12 K, respectively. The midpoint T_c observed here is nearly 20 times higher than that in the electric double-layer gated KTO(001) single crystal [26] and around 3 times higher than that in LAO/STO interfaces [2,11,12].

To investigate the nature of this interface superconductivity further, we measured the temperature-dependent $R_{\text{sheet}}(T)$'s under magnetic fields applied perpendicular and parallel to the interface. The result for the 20-nm sample is shown in Figs. 3(a) and 3(b). We found that application of a magnetic field $\mu_0 H$ (here μ_0 is the vacuum permeability) of ~ 0.6 T perpendicular (or ~ 6.0 T parallel) to the interface is needed to suppress the superconducting state. This strong anisotropy suggests that the superconductivity is 2D. Figures 3(c) and 3(d) show the temperature-dependent upper critical field $\mu_0 H_{c2}$ derived from the $R_{\text{sheet}}(T)$ curves in Figs. 3(a) and 3(b). The Ginzburg-Landau coherence length ξ_{GL} can be extracted using the linearized Ginzburg-Landau form [40,41] $\mu_0 H_{c2}^{\perp}(T) = [\emptyset_0/2\pi\xi_{GL}^2(0)][1 - (T/T_c)])$, where \emptyset_0 is the flux quantum and $\xi_{GL}(0)$ is the extrapolation of ξ_{GL} to T=0. Using the extrapolated $\mu_0 H_{c2}^{\perp}(0)=0.44$ T [Fig. 3(c)], we obtained $\xi_{GL}(0) = 27.3$ nm. For a 2D superconductor, $\mu_0 H_{c2}^{||}(T) = [\emptyset_0 \sqrt{12}/2\pi \xi_{\text{GL}}(0) d_{\text{sc}}][1 - (T/T_c)]^{1/2}$, where d_{sc} is the superconducting thickness [40,41]. Using the extrapolated $\mu_0 H_{c2}^{\parallel}(0) = 5.24$ T [Fig. 3(d)], we obtained $d_{\rm sc} = 8.0$ nm. With similar analysis, we obtained $\xi_{\rm GL}(0)$



FIG. 3. Transport behaviors under magnetic field for the 20-nm sample. Dependence of R_{sheet} on *T* for field (a) perpendicular and (b) parallel to the interface. Temperature dependence of upper critical field $\mu_0 H_{c2}$, extracted from the 50% normal-state resistance, (c) perpendicular and (d) parallel to the interface. The extrapolated $\mu_0 H_{c2}(0)$'s agree fairly well with that measured in the low-temperature magnetic-field-dependent resistance (Fig. S7).

and $d_{\rm sc}$ to be 41.0 and 7.7 nm, respectively, for the 6-nm sample. In both samples, $d_{\rm sc}$ is much smaller than $\xi_{\rm GL}(0)$, supporting the fact that the superconductivity is 2D in nature.

Assuming a single-band model, the mean free path $l_{\rm mfp}$ of the conducting electrons can be estimated using $k_F = \sqrt{2\pi n_{2D}}$ and $l_{\rm mfp} = (h/e^2)(1/k_F R_{\rm sheet})$, where k_F and h are the Fermi wave number and Planck's constant, respectively [41]. From the measured $n_{2D}(5 \text{ K})$ and $R_{\rm sheet}(5 \text{ K})$, the $l_{\rm mfp}$ of the present interfaces is estimated to be ~10 nm. This value is comparable with the superconducting layer thickness $d_{\rm sc}$ and is about 1/4-1/3 of $\xi_{\rm GL}$, suggesting that the superconductivity is in an intermediate range between clean ($l_{\rm mfp} \gg \xi_{\rm GL}$) and dirty ($\xi_{\rm GL} \gg l_{\rm mfp}$) limits.

To gain further insight into the superconductivity at the LAO/KTO(110) interface, we carried out current-voltage (I-V) measurements. The data for the 20-nm sample are shown in Fig. 4. Below T_c we find a clear critical current I_c , whose value decreases with increasing measurement temperature [Fig. 4(a) and its inset]. This is further evidence for the existence of superconductivity at the interface. The maximal value of I_c is ~3.4 mA/cm, which is more than 30 times higher than that observed for the superconducting LAO/STO interface [2].

For a 2D superconductor, the transition into the superconducting state is a Berezinskii-Kosterlitz-Thouless



FIG. 4. (a) Temperature-dependent *I-V* measurements for the 20-nm sample [the measured bridge is $20 \times 100 \ \mu m^2$, the central region of the Hall bar shown in Fig. 2(b)]. Inset: temperature dependence of the linear critical current density I_c . (b) *I-V* curves on a logarithmic scale. The symbol label is the same as that in (a). The long black line corresponds to $V \sim I^3$ dependence and shows that $0.87 < T_{BKT} < 0.88$ K. (c) Temperature dependence of the power-law exponent α , as deduced from the fits shown in (b). (d) $R_{\text{sheet}}(T)$ dependence of the same sample [the same data shown in Fig. 2(d)], plotted on a $[d \ln(R_{\text{sheet}})/dT]^{-2/3}$ scale. The solid line is the behavior expected for a BKT transition with $T_{\text{BKT}} = 0.92$ K.

(BKT) transition, characterized by a transition temperature $T_{\rm BKT}$ that corresponds to the unbinding of vortexantivortex pairs [2,42]. The BKT behavior would result in a $V \propto I^{\alpha}$ power-law dependence, with $\alpha(T_{\rm BKT}) = 3$, in *I-V* curves. As shown in Fig. 4(b), the power-law $V \propto I^{\alpha}$ dependence is seen. At T = 0.876 K, the exponent α approaches three [Fig. 4(c)]; this temperature is thus defined as $T_{\rm BKT}$. In addition, close to $T_{\rm BKT}$, a $R_{\rm sheet}(T) =$ $R_0 \exp[-b(T/T_{\rm BKT} - 1)^{-1/2}]$ dependence, where R_0 and *b* are material parameters, is expected [43]. As shown in Fig. 4(d), the measured $R_{\rm sheet}(T)$ is consistent with this dependence and yields $T_{\rm BKT} = 0.92$ K, in agreement with the analysis of the α exponent. Therefore, the superconducting transition of the LAO/KTO(110) samples is consistent with that of a 2D superconducting film.

Similar to LAO/STO interfaces [11,12,14], the Pauli paramagnetic limit is violated in the present LAO/KTO(110) interfaces. For a weak coupling BCS superconductor, the Pauli paramagnetic limit sets the upper bound for the parallel critical field [12,44,45], which is given by $\mu_0 H_{c2}^P \approx 1.76k_B T_c/\sqrt{2}\mu_B$, where k_B and μ_B are the Boltzmann's constant and Bohr magneton, respectively. Using $T_{BKT} = 0.92$ K as the superconducting transition temperature T_c , we obtained a $\mu_0 H_{c2}^P$ of 1.70 T, which is only about 1/3 of the measured $\mu_0 H_{c2}^{\parallel}$ (~5.24 T). In LAO/STO interfaces, the violation was proposed to be a consequence of strong spin-orbit coupling [12,14]. A similar mechanism is expected for the LAO/KTO(110) interfaces since KTO has a strong spin-orbit coupling strength due to the 5*d* tantalum atoms [24,33,46].

Finally, we discuss the possible origin of the interface superconductivity at LAO/KTO(110) interfaces. The present experiments do not allow us to determine the

underlying mechanism yet. However, several useful points may be given. (1) Parasite superconductivity from Al or Ta metal can be ruled out by structural characterizations (Figs. 1, S3, and S4) and also by the observation of relatively large upper critical fields (Figs. 3 and S7; note that the upper critical fields of Ta and Al metals are well below 0.1 T). (2) The determined thickness of the superconducting layer is ~ 8 nm, which rules out the possibility that the superconductivity originates from the interface La-Ta layer (~0.5 nm, Figs. 1 and S3). (3) Because LAO is amorphous, strain effect should be of less relevance [47]. (4) Because the measured Hall mobility is more than one order lower than that of electron-doped single-crystal KTO surfaces [26,34], the superconducting layer should contain relatively high-density disorders, most likely from oxygen vacancies, given that the interface intermixing is not significant.

Thus, the above points lead to a conclusion that the observed superconductivity is intrinsic to the interface KTO layer that is of a few nanometers. Since the bulk KTO is not known to be superconducting, we speculate that here the surface (interface) bands or phonons [48,49], as suggested by Ginzburg [48], play a determinant role. Because of various factors, such as symmetry breaking, atomic-orbital reconstruction, charge transfer, and quantum confinement, both the energy bands and phonon spectra of the interface KTO could be very different from that of the bulk KTO, which may result in metallic character and attraction between carriers [48,49]. Following this speculation, the strong dependence of superconductivity on the KTO orientation, as revealed by Liu et al. [27] and the present observations (also see Fig. S8 for LAO/KTO interfaces with three different orientations [28]), can be explained by the possible orientation-dependent surface

bands and phonon spectra. In addition, a simple comparison (Table S1) of the superconductivity at LAO/STO, EuO/KTO(111), and LAO/KTO(110) interfaces implies that higher T_c is favored by higher n_{2D} , thinner superconducting layer thickness, and higher density of disorders, which seems to partially support that electron-phonon coupling has a strong influence on the interface superconductivity. Further studies are needed for deeper understanding.

In conclusion, we have demonstrated that a conducting electron gas can be formed at the interface between LAO film and KTO(110) single crystal, which becomes superconducting at low temperatures with a T_c up to 0.9 K. This interface superconductivity is found to be 2D in nature, by the large anisotropy of the upper critical magnetic field and by the consistence with the BKT transition behaviors. The superconducting layer thickness and the coherence length are estimated to be ~8 and ~30 nm, respectively. Our present discovery provides a new model system for studying the rich physics of 2D superconductivity and other emergent phenomena at oxide interfaces.

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[®]To whom all correspondence should be addressed. ywxie@zju.edu.cn

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